

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Jung-wan KO et al.

Application No. 09/927,496

Group Art Unit: 2621

Confirmation No. 7491

Filed: August 13, 2001

Examiner: Huy Thanh Nguyen

For: METHOD OF AND APPARATUS FOR RECORDING DATA ON OPTICAL RECORDING  
MEDIUM

**LETTER TO THE EXAMINER REQUESTING CONFIRMATION OF INFORMATION  
DISCLOSURE STATEMENT CONSIDERED IN PARENT APPLICATION**

Commissioner for Patents  
PO Box 1450  
Alexandria, VA 22313-1450

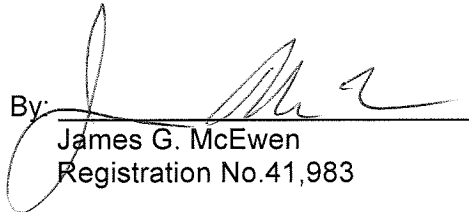
Sir:

Further to the Notice of Allowance mailed July 27, 2007, it is respectfully requested that the Examiner consider the attached references considered by the Examiner in parent application no. 09/263,816 under the procedures of MPEP 2001.06(b). Specifically, MPEP 2001.06(b) allows the applicant to ensure that any issuing patent lists references considered in the parent application. No requirement exists for a fee or a statement under 37 CFR §1.97 as consideration is presumed under MPEP 2001.06(b). Since the reference submitted on the attached Attachment 1(a) was previously considered in the parent application, U.S. Patent Application No. 09/263,816, consideration is presumed under MPEP 2001.06(b) and citation is being made to ensure the reference is listed on any issued patent.

Respectfully submitted,

STEIN, MCEWEN & BUI, LLP

Dated: SEPT. 18, 2007  
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Attachment 1(a)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 1293.1059CIP2D4	APPLICATION NO. 09/927,496
<b>LIST OF REFERENCES CITED BY APPLICANT</b>  <i>(Use several sheets if necessary)</i>		FIRST NAMED INVENTOR Jung-wan KO et al.	
		FILING DATE August 13, 2001	GROUP ART UNIT 2621

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	5,895,124	04/1999	Tsuga et al.			
	AB	6,283,764	09/2001	Kajiyama et al.			
	AC						
	AD						
	AE						
	AF						

**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO		ABSTRACT
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

**OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)**

							TRANSLATION YES NO	
	AM							

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.